

UNISONIC TECHNOLOGIES CO., LTD

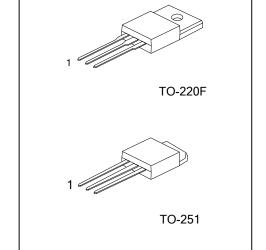
3N50Z **Preliminary Power MOSFET**

3.0A, 500V N-CHANNEL POWER MOSFET

DESCRIPTION

The UTC 3N50Z is an N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

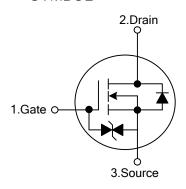
The UTC 3N50Z is generally applied in high efficiency switch mode power supplies, active power factor correction and electronic lamp ballasts based on half bridge topology.



FEATURES

- * $R_{DS(ON)}$ < 3.20 @ V_{GS} =10V, I_{D} =1.5A
- * High Switching Speed
- * 100% Avalanche Tested

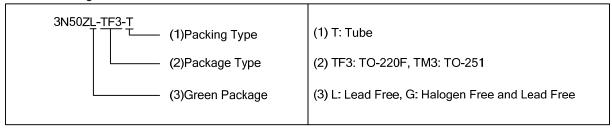
SYMBOL



ORDERING INFORMATION

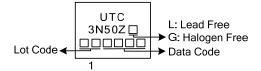
Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
3N50ZL-TF3-T	3N50ZG-TF3-T	TO-220F	G	D	S	Tube	
3N50ZL-TM3-T	3N50ZG-TM3-T	TO-251	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



www.unisonic.com.tw 1 of 7

■ MARKING



■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	500	V	
Gate-Source Voltage		V_{GSS}	±30	V	
Drain Current	Continuous (T _C =25°C)	I_{D}	3 (Note 5)	Α	
	Pulsed (Note 2)	I_{DM}	12 (Note 5)	Α	
Avalanche Current (Note 2)		I_{AR}	3	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	200	mJ	
	Repetitive (Note 4)	E_{AR}	6.2	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns	
Power Dissipation (T _C =25°C)	TO-220F	C	25	W	
	TO-251	P_D	50	W	
Junction Temperature		T_J	+150	°C	
Storage Temperature		T _{STG}	-55~+150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 40mH, I_{AS} = 3A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 4. $I_{SD} \le 3A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 5. Drain current limited by maximum junction temperature.

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220F	0	62.5	°C/W
	TO-251	θ_{JA}	110	°C/W
Junction to Case	TO-220F	θις	4.9	°C/W
	TO-251		2.5	°C/W

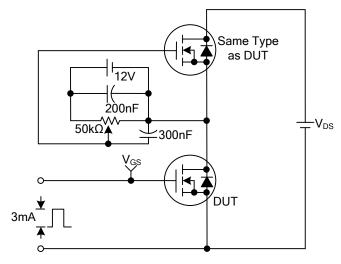
■ ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV_{DSS}	I _D =250μA, V _{GS} =0V	500			V	
Drain-Source Leakage Current		I_{DSS}	V _{DS} =500V, V _{GS} =0V			1	μA	
Gate- Source Leakage Current	Forward	- I _{GSS}	V_{GS} =+30V, V_{DS} =0V			+100	nA	
	Reverse		V_{GS} =-30V, V_{DS} =0V			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	2.0		4.0	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =1.5A		2.2	3.2	Ω	
DYNAMIC PARAMETERS								
Input Capacitance		C _{ISS}			280	365	pF	
Output Capacitance		Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		50	65	pF	
Reverse Transfer Capacitance		C_{RSS}			8.5	11	pF	
SWITCHING PARAMETERS								
Total Gate Charge		Q_{G}	V _{GS} =10V, V _{DS} =400V, I _D =3A		10	13	nC	
Gate to Source Charge		Q_GS	(Note 1, 2)		1.5		nC	
Gate to Drain Charge		Q_GD	(Note 1, 2)		5.5		nC	
Turn-ON Delay Time		$t_{D(ON)}$			10	30	ns	
Rise Time		t_R	V_{DD} =250V, I_{D} =3A, R_{G} =25 Ω		25	60	ns	
Turn-OFF Delay Time		$t_{D(OFF)}$	(Note 1, 2)		35	80	ns	
Fall-Time		t_{F}			25	60	ns	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current		Is				3	Α	
Maximum Body-Diode Pulsed Current		I _{SM}				12	Α	
Drain-Source Diode Forward Voltage		V_{SD}	I _S =3A, V _{GS} =0V			1.4	V	
Body Diode Reverse Recovery Time		t _{rr}	I _S =3A, V _{GS} =0V,		170		ns	
Body Diode Reverse Recovery Charge		Qrr	dI _F /dt=100A/µs (Note 1)		0.7		μC	

Notes: 1. Pulse Test: Pulse width \leq 300 μ s, Duty cycle \leq 2%.

^{2.} Essentially independent of operating temperature.

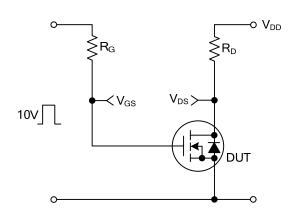
TEST CIRCUITS AND WAVEFORMS



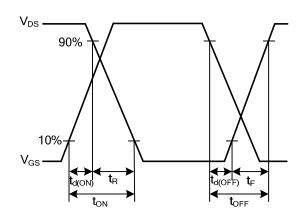
10V Q_G Q_G Charge

Gate Charge Test Circuit

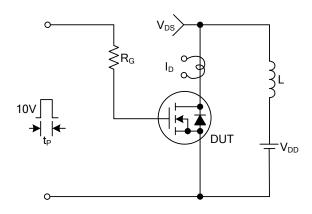
Gate Charge Waveforms



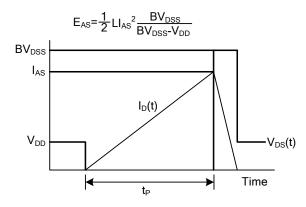
Resistive Switching Test Circuit



Resistive Switching Waveforms

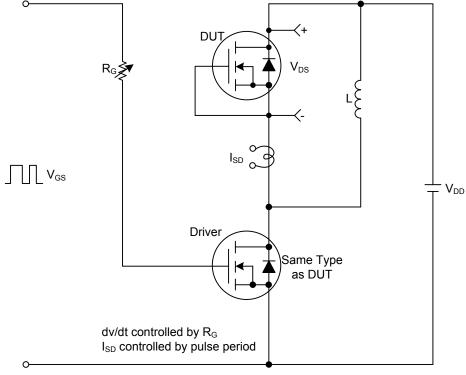


Unclamped Inductive Switching Test Circuit

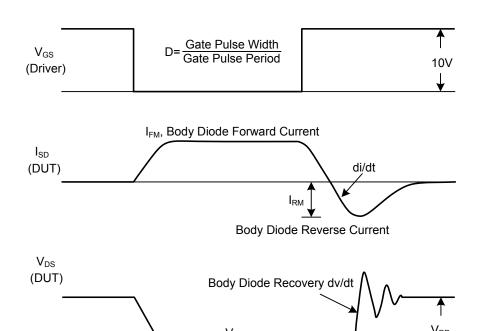


Unclamped Inductive Switching Waveforms

■ TEST CIRCUITS AND WAVEFORMS(Cont.)



Peak Diode Recovery dv/dt Test Circuit & Waveforms



Body Diode Forward Voltage Drop

UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice.

